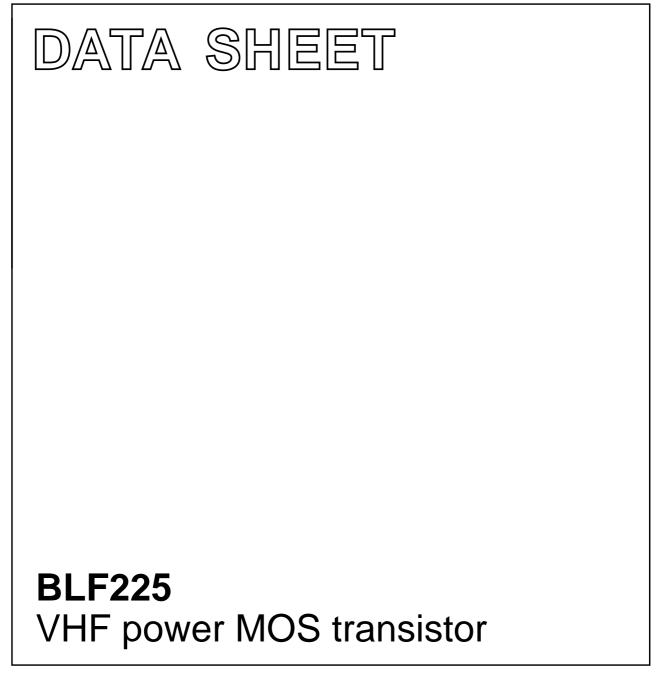
DISCRETE SEMICONDUCTORS



Product specification

September 1992



HILIPS

# **BLF225**

### FEATURES

- · Easy power control
- · Good thermal stability
- Withstands full load mismatch.

### DESCRIPTION

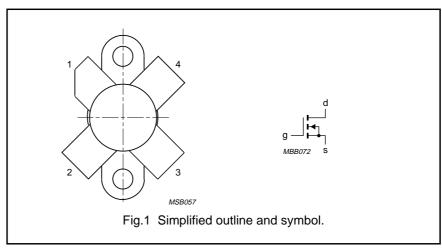
Silicon N-channel enhancement mode vertical D-MOS transistor designed for communications transmitter applications in the VHF frequency range.

The transistor is encapsulated in a 4-lead, SOT123 flange envelope, with a ceramic cap. All leads are isolated from the flange.

#### **PINNING - SOT123**

PIN	DESCRIPTION	
1	drain	
2	source	
3	gate	
4	source	

#### **PIN CONFIGURATION**



### CAUTION

The device is supplied in an antistatic package. The gate-source input must be protected against static charge during transport and handling.

#### WARNING

### Product and environmental safety - toxic materials

This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

#### QUICK REFERENCE DATA

RF performance at T<sub>h</sub> = 25 °C in a common source test circuit.

MODE OF OPERATION	f	V <sub>DS</sub>	P <sub>L</sub>	G <sub>p</sub>	η <sub>D</sub>
	(MHz)	(V)	(W)	(dB)	(%)
CW, class-B	175	12.5	30	> 8.5	> 60

**BLF225** 

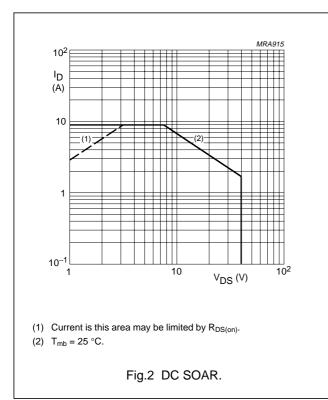
#### LIMITING VALUES

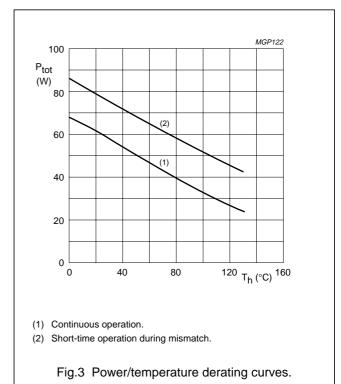
In accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>DS</sub>	drain-source voltage		_	40	V
±V <sub>GS</sub>	gate-source voltage		-	20	V
I <sub>D</sub>	DC drain current		-	9	А
P <sub>tot</sub>	total power dissipation	up to $T_{mb} = 25 \ ^{\circ}C$	_	68	W
T <sub>stg</sub>	storage temperature		-65	150	°C
Tj	junction temperature		_	200	°C

### THERMAL RESISTANCE

SYMBOL	PARAMETER	THERMAL RESISTANCE
R <sub>th j-mb</sub>	thermal resistance from junction to mounting base	2.6 K/W
R <sub>th mb-h</sub>	thermal resistance from mounting base to heatsink	0.3 K/W



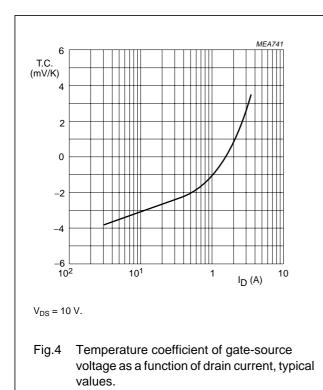


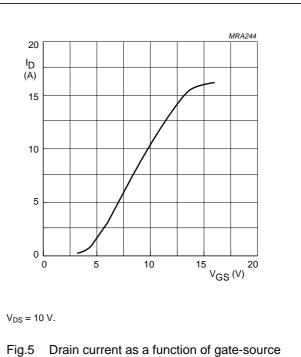
### **BLF225**

#### CHARACTERISTICS

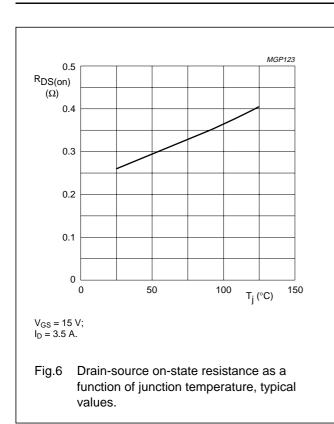
 $T_{j}$  = 25 °C unless otherwise specified.

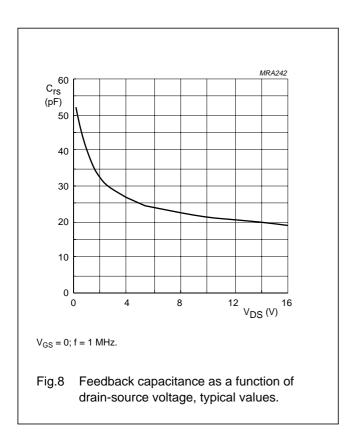
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	V <sub>GS</sub> = 0; I <sub>D</sub> = 30 mA	40	_	_	V
I <sub>DSS</sub>	drain-source leakage current	V <sub>GS</sub> = 0; V <sub>DS</sub> = 12.5 V	-	_	1	mA
I <sub>GSS</sub>	gate-source leakage current	$\pm V_{GS} = 20 \text{ V}; \text{ V}_{DS} = 0$	-	-	1	μΑ
V <sub>GS(th)</sub>	gate-source threshold voltage	I <sub>D</sub> = 30 mA; V <sub>DS</sub> = 10 V	2	-	4.5	V
9 <sub>fs</sub>	forward transconductance	I <sub>D</sub> = 3.5 A; V <sub>DS</sub> = 10 V	1.5	2.2	-	S
R <sub>DS(on)</sub>	drain-source on-state resistance	I <sub>D</sub> = 3.5 A; V <sub>GS</sub> = 15 V	-	0.25	0.35	Ω
I <sub>DSX</sub>	on-state drain current	$V_{GS} = 15 \text{ V}; V_{DS} = 10 \text{ V}$	-	16	-	А
C <sub>is</sub>	input capacitance	V <sub>GS</sub> = 0; V <sub>DS</sub> = 12.5 V; f = 1 MHz	-	120	-	pF
C <sub>os</sub>	output capacitance	V <sub>GS</sub> = 0; V <sub>DS</sub> = 12.5 V; f = 1 MHz	-	140	-	pF
C <sub>rs</sub>	feedback capacitance	$V_{GS} = 0; V_{DS} = 12.5 V; f = 1 MHz$	-	20	-	pF

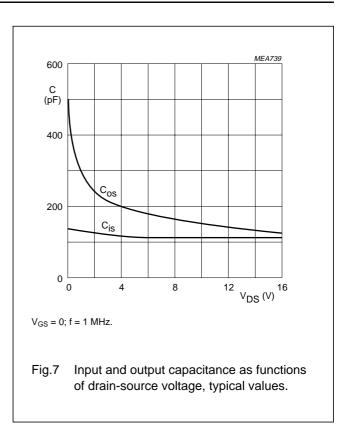




J.5 Drain current as a function of gate-soul voltage, typical values.







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### APPLICATION INFORMATION FOR CLASS-B OPERATION

 $T_{h}$  = 25 °C;  $R_{th\,mb\text{-}h}$  = 0.3 K/W; unless otherwise specified.

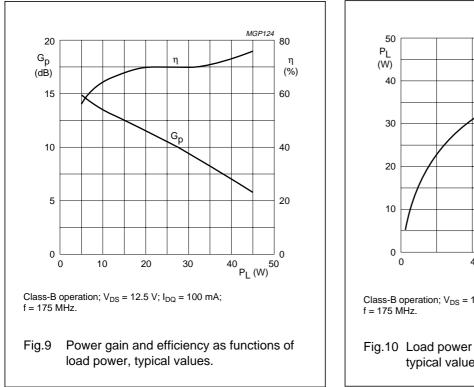
RF performance in CW operation in a common source class-B test circuit.

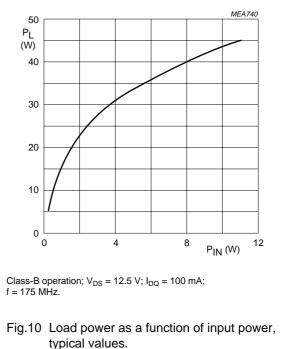
MODE OF OPERATION	f	V <sub>DS</sub>	I <sub>DQ</sub>	P <sub>L</sub>	G <sub>P</sub>	ղշ
	(MHz)	(V)	(mA)	(W)	(dB)	<b>(%)</b>
CW, class-B	175	12.5	100	30	> 8.5 typ. 9.5	> 60 typ. 70

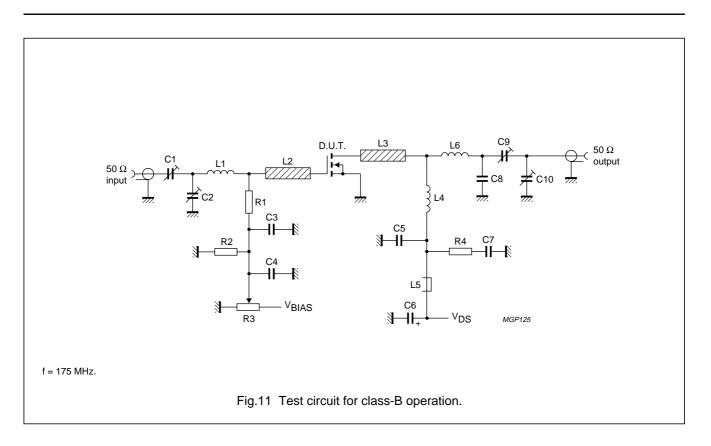
#### Ruggedness in class-B- operation

The BLF225 is capable of withstanding a load mismatch corresponding to VSWR = 50 through all phases under the following conditions:

 $V_{DS}$  = 15.5 V; f = 175 MHz at rated load power.







**BLF225** 

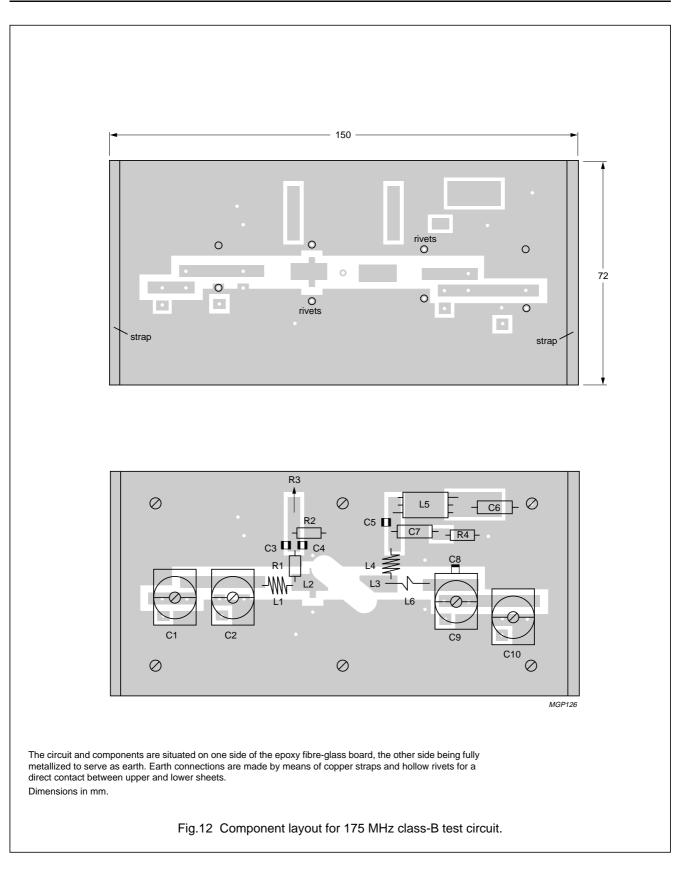
#### List of components (class-B test circuit)

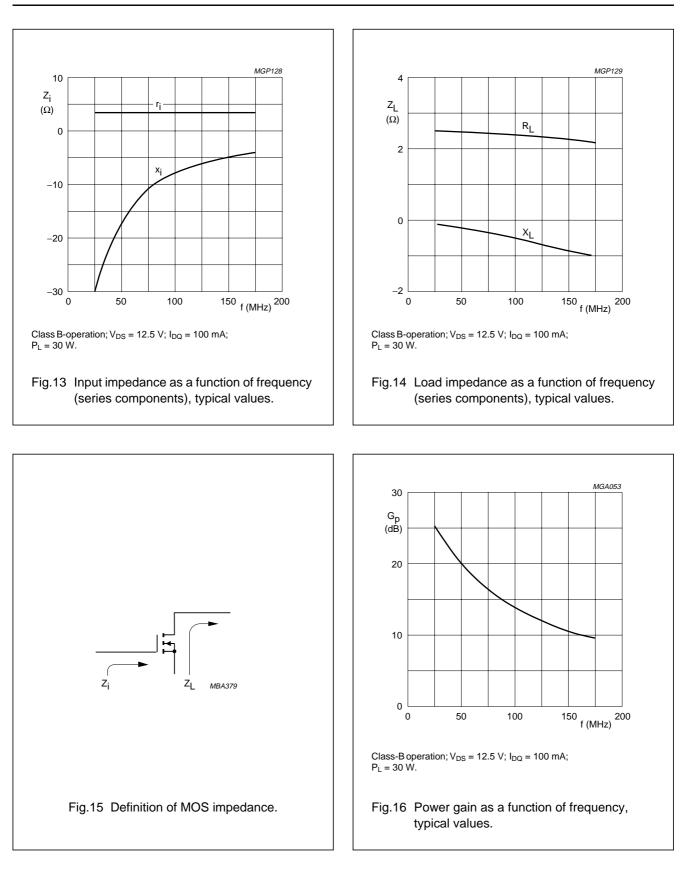
COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1	film dielectric trimmer	4 to 40 pF		2222 809 07008
C2, C10	film dielectric trimmer	5 to 60 pF		2222 809 07011
C3	multilayer ceramic chip capacitor (note 1)	100 pF, 500 V		
C4	ceramic chip capacitor	100 nF, 50 V		2222 852 47104
C5	multilayer ceramic chip capacitor (note 1)	680 pF, 500 V		
C6	electrolytic capacitor	10 μF, 63 V		2222 030 38109
C7	polyester capacitor	100 nF, 250 V		
C8	multilayer ceramic chip capacitor (note 1)	43 pF, 500 V		
C9	film dielectric trimmer	7 to 100 pF		2222 809 07015
L1	3 turns enamelled 0.5 mm copper wire	18 nH	length 3.3 mm int. dia. 2 mm leads $2 \times 5$ mm	
L2, L3	stripline (note 2)	31 Ω	12 × 6 mm	
L4	3 turns enamelled 1.5 mm copper wire	28 nH	length 8.2 mm int. dia. 4 mm leads $2 \times 5$ mm	
L5	grade 3B Ferroxcube RF choke			4312 020 36642
L6	1 turn enamelled 1.5 mm copper wire	36 nH	length 4 mm int. dia. $3.5$ mm leads 2 $\times$ 5 mm	
R1	0.4 W metal film resistor	1 kΩ		2322 151 51002
R2	0.4 W metal film resistor	1 MΩ		2322 151 51005
R3	10 turns cermet potentiometer	5 kΩ		
R4	0.4 W metal film resistor	10 Ω		2322 151 51009

#### Notes

1. American Technical Ceramics (ATC) capacitor, type 100B or other capacitor of the same quality.

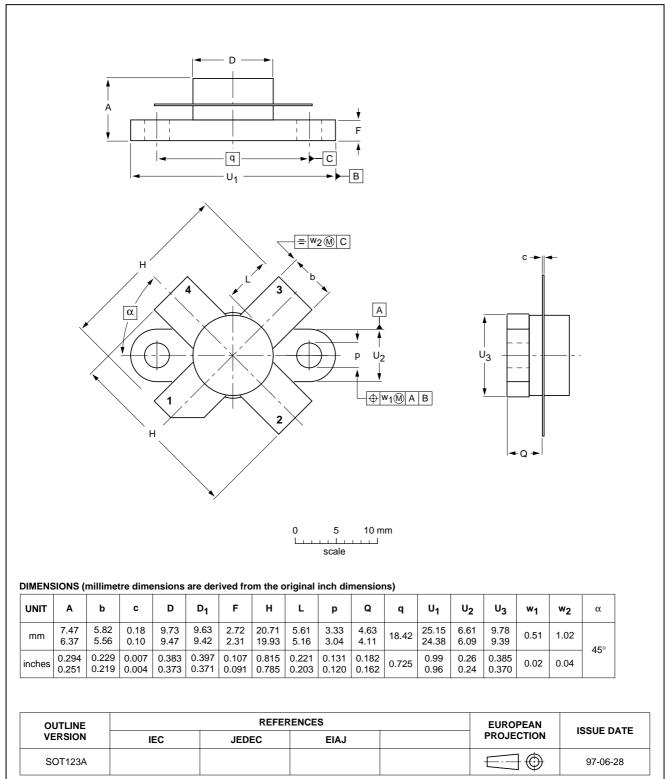
2. The striplines are on a double copper-clad printed circuit board, with epoxy fibre-glass dielectric ( $\epsilon_r$  = 4.5), thickness  $1/_{16}$  inch.





#### PACKAGE OUTLINE

### Flanged ceramic package; 2 mounting holes; 4 leads



**BLF225** 

SOT123A

Product specification

### **BLF225**

#### DEFINITIONS

Data Sheet Status					
Objective specification	This data sheet contains target or goal specifications for product development.				
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.				
Product specification	This data sheet contains final product specifications.				
Limiting values					
Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.					

### Application information

Where application information is given, it is advisory and does not form part of the specification.

#### LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.